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Please note: As part of the Fairchild Semiconductor integration, some of the Fairchild orderable part numbers will need to change in order to meet ON Semiconductor's system requirements. Since the ON Semiconductor product management systems do not have the ability to manage part nomenclature that utilizes an underscore (_), the underscore (_) in the Fairchild part numbers will be changed to a dash (-). This document may contain device numbers with an underscore (_). Please check the ON Semiconductor website to verify the updated device numbers. The most current and up-to-date ordering information can be found at www.onsemi.com. Please email any questions regarding the system integration to Fairchild <a href="general-regarding-numbers-n

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November 2013

FDMS030N06B

N-Channel PowerTrench[®] MOSFET 60 V, 100 A, 3 m Ω

Features

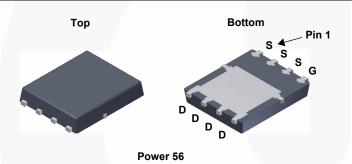
- $R_{DS(on)}$ = 2.4 m Ω (Typ.) @ V_{GS} = 10 V, I_D = 50 A
- Advanced Package and Silicon Combination for Low R_{DS(on)} and High Efficiency
- · Fast Switching Speed
- · 100% UIL Tested
- · RoHS Compliant

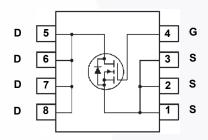
Description

This N-Channel MOSFET is produced using Fairchild Semiconductor's advance PowerTrench® process that has been tailored to minimize the on-state resistance while maintaining superior switching performance.

Applications

- Synchronous Rectification for ATX / Server / Telecom PSU
- · Battery Protection Circuit
- · Motor drives and Uninterruptible Power Supplies
- · Renewable system





MOSFET Maximum Ratings T_C = 25°C unless otherwise noted.

Symbol		Parameter		FDMS030N06B	Unit
V _{DSS}	Drain to Source Voltage			60	V
V _{GSS}	Gate to Source Voltage			±20	V
I _D	Drain Current	- Continuous (T _C = 25°C)	(Note1)	100	۸
		- Continuous (T _A = 25°C)	(Note 2a)	22.1	Α
I _{DM}	Drain Current	- Pulsed	(Note 3)	400	Α
E _{AS}	Single Pulsed Avalanche Energ	у	(Note 4)	248	mJ
D	Dawer Dissination	(T _C = 25°C)		104	W
P_{D}	Power Dissipation	(T _A = 25°C)	(Note 2a)	2.5	W
T _J , T _{STG}	Operating and Storage Tempera	ature Range		-55 to +150	οС

Thermal Characteristics

Symbol	Parameter	FDMS030N06B	Unit
$R_{\theta JC}$	Thermal Resistance, Junction to Case, Max.	1.2	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient, Max. (Note 2a	50	30/00

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMS030N06B	FDMS030N06B	Power 56	13 "	12 mm	3000 units

Electrical Characteristics $T_C = 25^{\circ}C$ unless otherwise noted.

Parameter	Test Conditions	Min.	Тур.	Max.	Unit
cteristics					
Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	60	-	-	V
Breakdown Voltage Temperature Coefficient	I_D = 250 μA, Referenced to 25°C	-	0.03	-	V/°C
Zero Gate Voltage Drain Current	V _{DS} = 48 V, V _{GS} = 0 V	-	-	1	μΑ
Gate to Body Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$	-	-	±100	nA
	Drain to Source Breakdown Voltage Breakdown Voltage Temperature Coefficient Zero Gate Voltage Drain Current	Cteristics Drain to Source Breakdown Voltage $I_D = 250 \mu A$, $V_{GS} = 0 V$ Breakdown Voltage Temperature Coefficient $I_D = 250 \mu A$, Referenced to 25° C Zero Gate Voltage Drain Current $V_{DS} = 48 \text{ V}$, $V_{GS} = 0 \text{ V}$	Cteristics Drain to Source Breakdown Voltage $I_D = 250 \mu A$, $V_{GS} = 0V$ 60 Breakdown Voltage Temperature Coefficient $I_D = 250 \mu A$, Referenced to $25^{\circ}C$ - Zero Gate Voltage Drain Current $V_{DS} = 48 \text{ V}$, $V_{GS} = 0 \text{ V}$ -		

On Characteristics

V _{GS(th)}	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$	2.5	3.3	4.5	V
R _{DS(on)}	Static Drain to Source On Resistance	V _{GS} = 10 V, I _D = 50 A	-	2.4	3.0	$m\Omega$
9 _{FS}	Forward Transconductance	V _{DS} = 10 V, I _D = 50 A	-	119	-	S

Dynamic Characteristics

C _{iss}	Input Capacitance	V _{DS} = 30 V, V _{GS} = 0 V	-	5685	7560	pF
C _{oss}	Output Capacitance		-	1720	2290	pF
C _{rss}	Reverse Transfer Capacitance	1 - 1 1011 12	-	59	-	pF
C _{oss} (er)	Engry Releted Output Capacitance	V _{DS} = 30 V, V _{GS} = 0 V	-	2504	-	pF
Q _{g(tot)}	Total Gate Charge at 10V		-\	75	-	nC
Q_{gs}	Gate to Source Gate Charge	$V_{DS} = 30 \text{ V}, I_{D} = 50 \text{ A}$	- \	30	-	nC
Q_{gd}	Gate to Drain "Miller" Charge	V _{GS} = 0 V to 10 V	- 1	14	-	nC
V _{plateau}	Gate Plateau Volatge	(Note 5)	-	5.4	-	V
Q _{sync}	Total Gate Charge Sync.	V _{DS} = 0 V, I _D = 50 A	-	66.2	-	nC
Q _{oss}	Output Charge	V _{DS} = 30 V, V _{GS} = 0 V	-	174	-	nC
ESR	Equivalent Series Resistance	f = 1 MHz	-	1.05	-	Ω

Switching Characteristics

t _{d(on)}	Turn-On Delay Time		-	39	88	ns
t _r	Turn-On Rise Time	$V_{DD} = 30 \text{ V}, I_{D} = 50 \text{ A}$	-	20	50	ns
t _{d(off)}	Turn-Off Delay Time	$V_{GS} = 10 \text{ V}, R_{G} = 4.7 \Omega$	-	52	114	ns
t _f	Turn-Off Fall Time	(Note 5)	-	16	42	ns

Drain-Source Diode Characteristics

I _S	Maximum Continuous Drain to Source Diode Forward Current		-	-	100	Α
I _{SM}	Maximum Pulsed Drain to Source Diode Forward Current			-	400	Α
V_{SD}	Drain to Source Diode Forward Voltage	V _{GS} = 0 V, I _{SD} = 50 A	-	-	1.25	V
t _{rr}	Reverse Recovery Time	V _{GS} = 0 V, I _{SD} = 50 A	-	71	-	ns
Q _{rr}	Reverse Recovery Charge	$dI_F/dt = 100 A/\mu s$	-	85	-	nC

Notes:

- 1. Silicon limited I_D rating = 147 A.
 2. R_{6JA} is determined with the device mounted on a 1in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{6JC} is guaranteed by design while R_{6CA} is determined by the user's board design.



a. 50 °C/W when mounted on a 1 in² pad of 2 oz copper.

b. 125 °C/W when mounted on a minimum pad of 2 oz copper.



- ${\it 3. Repetitive\ rating: pulse-width\ limited\ by\ maximum\ junction\ temperature.}$
- 4. L = 0.3 mH, I_{AS} = 40.7 A, V_{DD} = 50 V, V_{GS} = 10 V, starting T_J = 25°C.
- 5. Essentially independent of operating temperature typical characteristics.

Typical Performance Characteristics

Figure 1. On-Region Characteristics 200 100 ID, Drain Current[A] V_{GS} = 15.0V 10.0V 8.0V 7.0V 6.5V *Notes: 6.0V 1. 250µs Pulse Test 5.5V 2. $T_C = 25^{\circ}C$ 5.0V 0.05 0.1 V_{DS}, Drain-Source Voltage[V]

Figure 3. On-Resistance Variation vs.

Drain Current and Gate Voltage

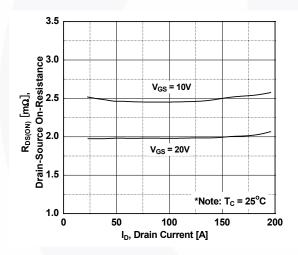


Figure 5. Capacitance Characteristics

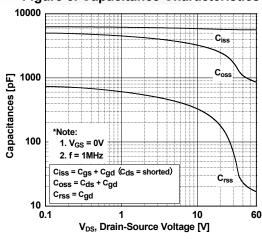


Figure 2. Transfer Characteristics

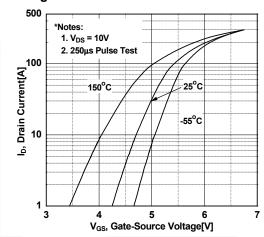


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

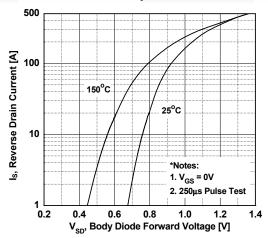
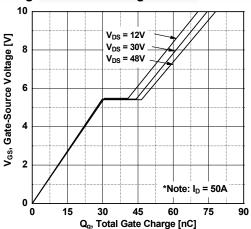


Figure 6. Gate Charge Characteristics



Typical Performance Characteristics (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

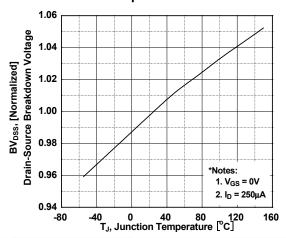


Figure 9. Maximum Safe Operating Area

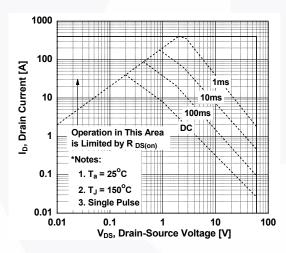


Figure 11. Eoss vs. Drain to Source Voltage

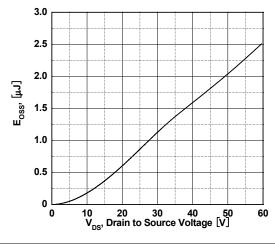


Figure 8. On-Resistance Variation vs. Temperature

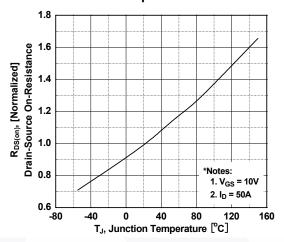


Figure 10. Maximum Drain Current vs. Case Temperature

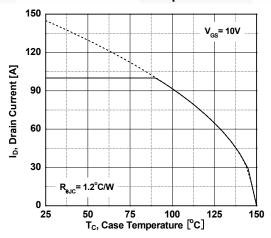
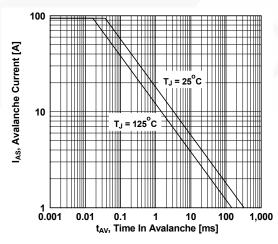


Figure 12. Unclamped Inductive Switching Capability



Typical Performance Characteristics (Continued)

Figure 13. Transient Thermal Response Curve

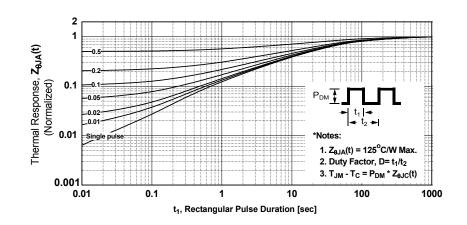


Figure 14. Gate Charge Test Circuit & Waveform

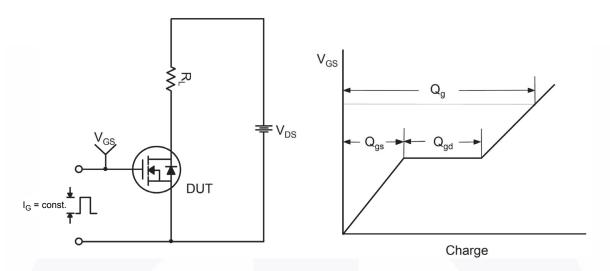


Figure 15. Resistive Switching Test Circuit & Waveforms

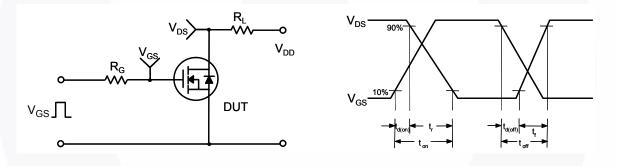
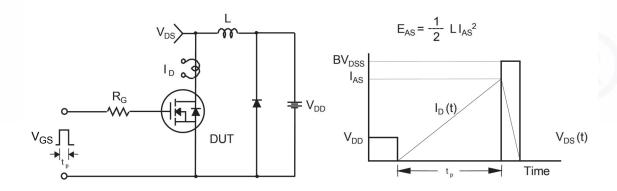


Figure 16. Unclamped Inductive Switching Test Circuit & Waveforms



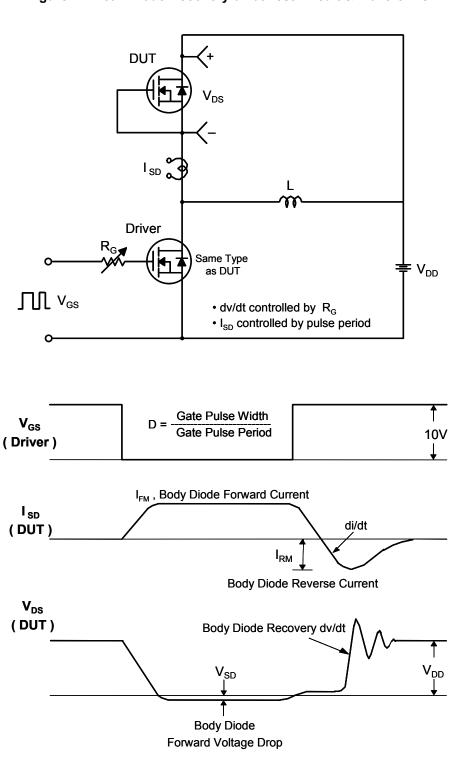
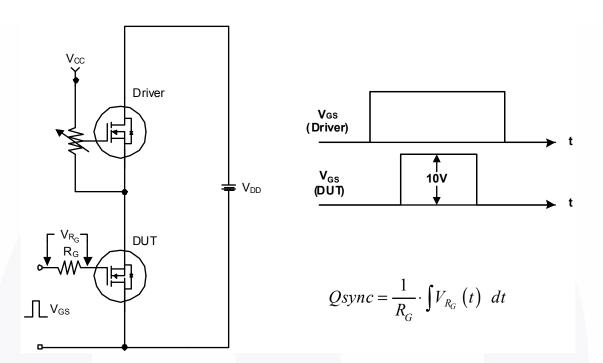


Figure 17. Peak Diode Recovery dv/dt Test Circuit & Waveforms

Figure 18. Total Gate Charge Qsync. Test Circuit & Waveforms





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